

<b>Notice of References Cited</b>	Application/Control No. 10/579,285	Applicant(s)/Patent Under Reexamination REINHARDT ET AL.	
	Examiner Hai H. Huynh	Art Unit 3747	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,371,548	03-1945	SAFFADY THOMAS F	123/41.16
*	B	US-4,164,957	08-1979	Goloff, Alexander	137/340
*	C	US-5,413,073	05-1995	Larson et al.	123/188.3
*	D	US-5,458,314	10-1995	Bonesteel, David L.	251/337
*	E	US-5,771,852	06-1998	Heimann et al.	123/188.3
*	F	US-5,823,158	10-1998	Heimann et al.	123/188.3
*	G	US-6,006,713	12-1999	Gebauer, Klaus	123/188.3
*	H	US-6,263,849	07-2001	Bonesteel et al.	123/90.51
*	I	US-6,935,296	08-2005	Abele et al.	123/188.3
*	J	US-7,240,895	07-2007	Abele et al.	251/356
*	K	US-2006/0278193 A1	12-2006	Abele, Marcus	123/188.3
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.